

**ON Semiconductor®** 

FCH041N60F-F085

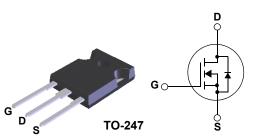
# N-Channel SuperFET II FRFET MOSFET 600 V, 76 A, 41 m $\Omega$

## Features

- Typical  $R_{DS(on)}$  = 36 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 38 A
- Typical Q<sub>g(tot)</sub> = 267 nC at V<sub>GS</sub> = 10V, I<sub>D</sub> = 38 A
- Low Effective Output Capacitance (Typical C<sub>oss(eff.)</sub> = 720 nF)
- 100% Avalanche Tested
- Qualified to AEC Q101
- RoHS Compliant

## Description

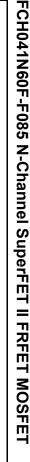
SuperFET® II MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently SuperFETII is very well suited for the Soft switching and Hard Switching topologies like High Voltage Full Bridge and Half Bridge DC-DC, Interleaved Boost PFC, Boost PFC for HEV-EV automotive. SuperFETI II FRET® MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.



## Application

Automotive On Board Charger

Automotive DC/DC converter for HEV



## **Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain to Source Voltage		600	V	
V <sub>GS</sub>	Gate to Source Voltage		±20	V	
I <sub>D</sub>	Drain Current - Continuous (V <sub>GS</sub> =10)	T <sub>C</sub> = 25°C	76	А	
	Pulsed Drain Current		See Fig 4	А	
E <sub>AS</sub>	Single Pulse Avalanche Rating	(Note 1)	2025	mJ	
dv/dt	MOSFET dv/dt		100	V/ns	
	Peak Diode Recovery dv/dt	(Note 2)	50	v/115	
P <sub>D</sub>	Power Dissipation		595	W	
	Derate Above 25°C		4.76	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to + 150	°C	
$R_{\theta JC}$	Maximum Thermal Resistance Junction to Case		0.21	°C/W	
$R_{ ext{ heta}JA}$	Maximum Thermal Resistance Junction to Ambient	(Note 3)	40	°C/W	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCH041N60F	FCH041N60F-F085	TO-247	-	-	30

Notes:

1: Starting  $T_J = 25^{\circ}$ C, L = 18mH,  $I_{AS} = 15A$ ,  $V_{DD} = 100V$  during inductor charging and  $V_{DD} = 0V$  during time in avalanche.

2:  $I_{SD} \le 38A$ , di/dt  $\le 200 \text{ A/us}$ ,  $V_{DD} \le 380V$ , starting  $T_J = 25^{\circ}C$ .

3:  $R_{0,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0,JC}$  is guaranteed by design, while  $R_{0,JA}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Cha	racteristics					
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V	600	-	-	V
I <sub>DSS</sub>	Drain to Source Leakage Current	$V_{DS}$ =600V, $T_{J}$ = 25°C	-	-	10	μA
	Drain to Source Leakage Current	$V_{GS} = 0V$ $T_J = 150^{\circ}C(Note 4)$	-	-	1	mA
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V	-	-	±100	nA
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$		4	5	V
On Cha	racteristics					
r <sub>DS(on)</sub>	Drain to Source On Resistance	$I_D = 38A,$ $T_J = 25^{\circ}C$ $V_{GS} = 10V$ $T_J = 150^{\circ}C(Note 5)$	-	36 89	41 98	mΩ mΩ
<b>Dynam</b> i C <sub>iss</sub>	ic Characteristics	V 400V V 0V	_	10900	-	pF
C <sub>oss</sub>	Output Capacitance	─V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V, f = 1MHz	-	360	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	4.4	-	pF
C <sub>oss(eff)</sub>	Effective Output Capacitance	$V_{DS}$ = 0V to 480V, $V_{GS}$ = 0V	-	720	-	pF
( )	Gate Resistance	f = 1MHz	-	0.7	-	Ω
R <sub>g</sub>			-	267	347	nC
R <sub>g</sub> Q <sub>g(ToT)</sub>	Total Gate Charge	11 00011				
Q <sub>g(ToT)</sub>	Threshold Gate Charge	$V_{DD} = 380V$	-	20	26	nC
$\frac{R_g}{Q_{g(ToT)}}$ $\frac{Q_{g(th)}}{Q_{gs}}$	Č Č	V <sub>DD</sub> = 380V I <sub>D</sub> = 38A V <sub>GS</sub> = 10V	-	20 59	26 -	nC nC

## **Switching Characteristics**

t <sub>on</sub>	Turn-On Time		-		242	ns
t <sub>d(on)</sub>	Turn-On Delay Time		-	63	-	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 380V, I <sub>D</sub> = 38A, V <sub>GS</sub> = 10V, R <sub>G</sub> = 4.7Ω	-	48	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10V, R <sub>G</sub> = 4.7Ω	-	214	-	ns
t <sub>f</sub>	Fall Time		-	33	-	ns
t <sub>off</sub>	Turn-Off Time		-	-	514	ns

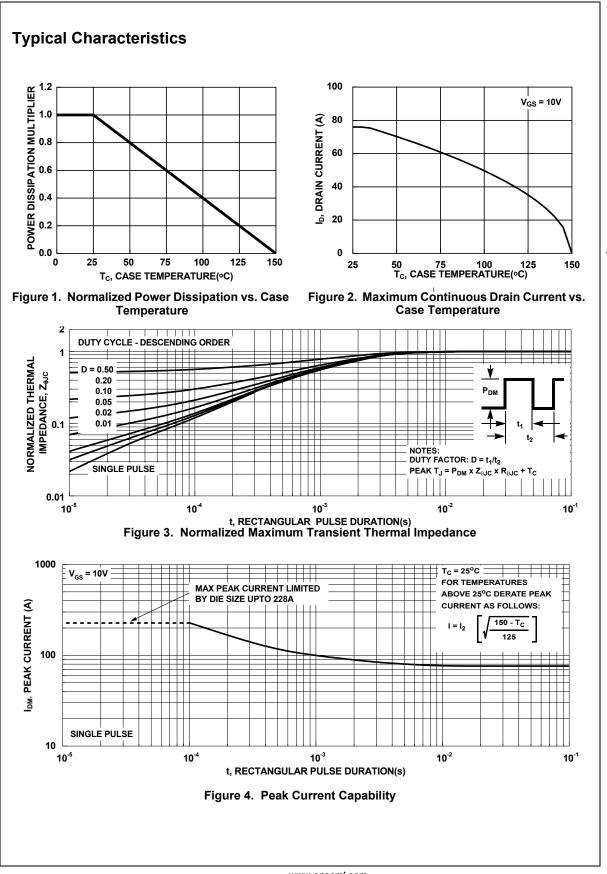
## **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Voltage	I <sub>SD</sub> = 38A, V <sub>GS</sub> = 0V	-	-	1.2	V
T <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 38A, dI <sub>SD</sub> /dt = 100A/μs	-	219	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DD</sub> = 480V	-	1.9	-	μC

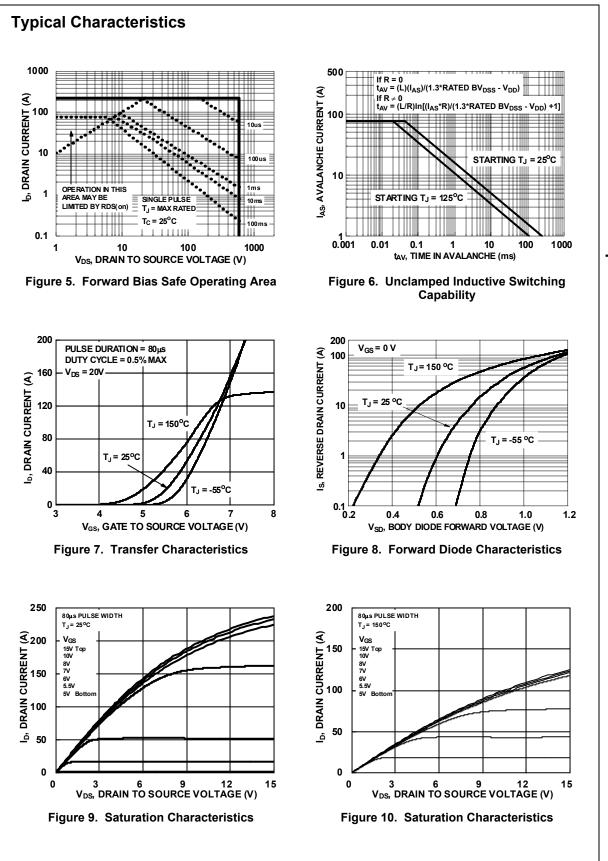
## Notes:

4: The maximum value is specified by design at  $T_J = 150^{\circ}$ C. Product is not tested to this condition in production.

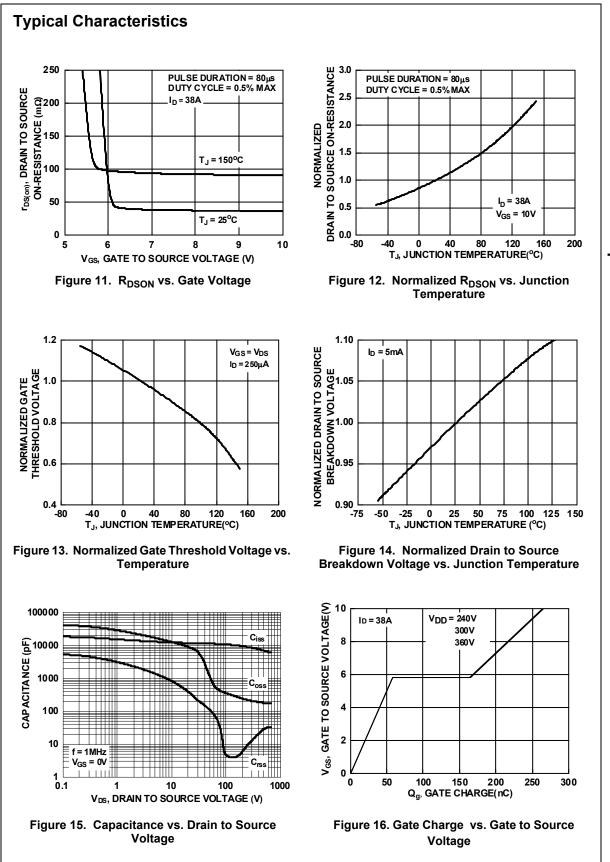




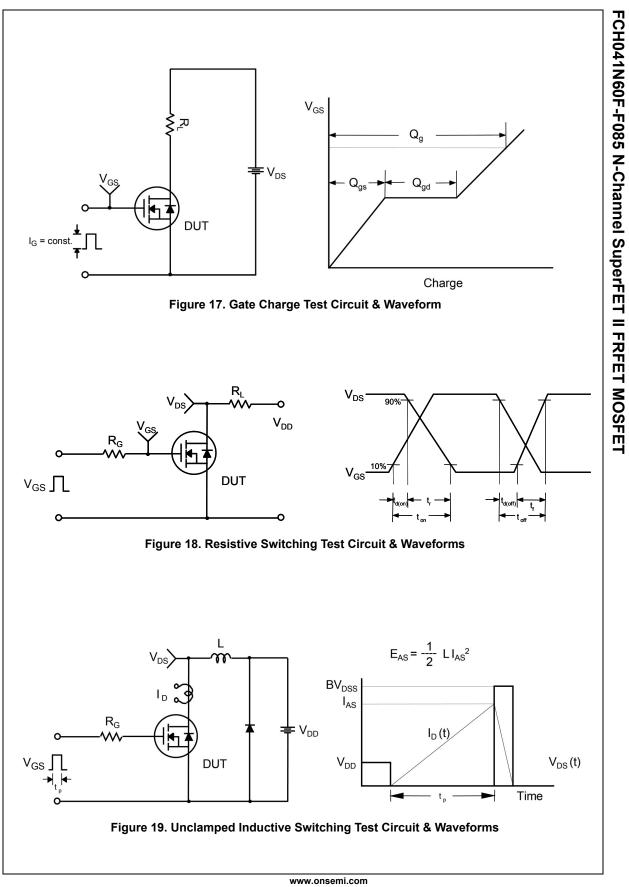
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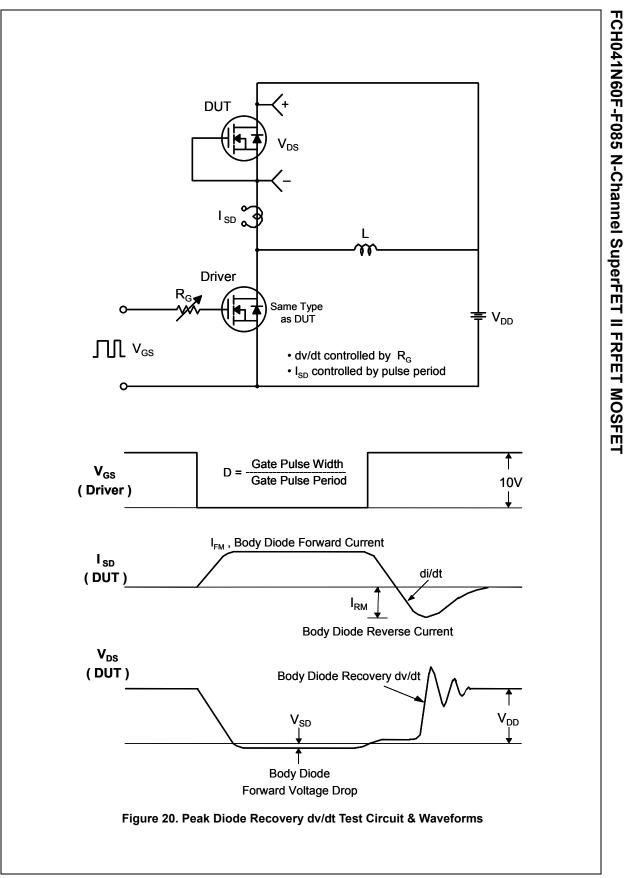
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